Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | DIANA ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2003/0224535	12-2003	Andideh et al.	438/3
	В	US-2002/0197844	12-2002	Johnson et al.	438/618
	С	US-2003/0107067	06-2003	Gudesen, Hans Gude	257/295
	D	US-2003/0017627	01-2003	Li et al.	438/3
	Е	US-6,670,659	12-2003	Gudesen et al.	257/295
	F	US-			1
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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	x	

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